

**Search Notes**

Application/Control No.

10/005,208

Examiner

Khai M. Nguyen

Applicant(s)/Patent under  
Reexamination

BECKER ET AL.

Art Unit

2687

**SEARCHED**

Class	Subclass	Date	Examiner
455	151.4 151.2 151.1 569.2 575.9	11/19/2005	KN
455	345 41.2	11/19/2005	KN
455	41.3	11/19/2005	KN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
ease (see attached)		KN